

<b>Notice of References Cited</b>	Application/Control No. 10/822,748	Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner Nicole Blan	Art Unit 1792	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,887,456	03-1999	Tanigawa et al.	68/20
*	B	US-6,117,219	09-2000	Muhr, Hans	96/224
*	C	US-4,684,064	08-1987	Kwok, Kui-Chiu	239/223
*	D	US-6,183,175	02-2001	Gafner, Rudolf	409/74
*	E	US-7,047,666	05-2006	Hahn et al.	34/499
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 200111134 A1	02-2001	World Intellect	ROSEEN, R	—
	O	DE 10260156 A1	07-2004	Germany	HAHN et al.	—
	P	EP 1431443 A1	06-2004	European Patent	HAHN et al.	—
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.